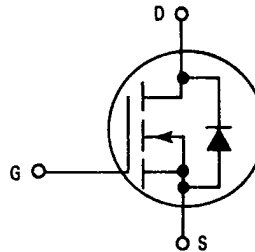


# MOTOROLA SEMICONDUCTOR TECHNICAL DATA

## Designer's Data Sheet Power Field Effect Transistor N-Channel Enhancement Mode Silicon Gate TMOS

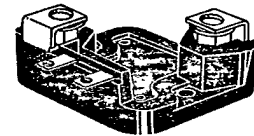
These TMOS Power FETs are designed for high current, high speed power switching applications such as switching regulators, converters, and motor controls.

- $I_{DSS}$ ,  $V_{DS(on)}$ , SOA and  $V_{GS(th)}$  Specified at Elevated Temperature
- Rugged — SOA is Power Dissipation Limited
- High  $di/dt$  Capability
- Silicon Gate for Fast Switching Speeds
- Multi-chip Construction
- Gates Internally Decoupled



**MTE50N45**  
**MTE50N50**  
**MTE60N35**  
**MTE60N40**

TMOS POWER FETs  
50 and 60 AMPERES  
 $r_{DS(on)} = 0.075 \text{ OHM}$   
350 and 400 VOLTS  
 $r_{DS(on)} = 0.100 \text{ OHM}$   
450 and 500 VOLTS



CASE 346-01  
MO-040AA

### MAXIMUM RATINGS

| Rating   | Symbol         | MTE   |       |       |       | Unit                         |
|--|----------------|---|-------|-------|-------|------------------------------|
|  |                | 60N35   | 60N40 | 50N45 | 50N50 |                              |
| Drain-Source Voltage   | $V_{DSS}$      | 350   | 400   | 450   | 500   | Vdc                          |
| Drain-Gate Voltage<br>( $R_{GS} = 1 \text{ M}\Omega$ )                                   | $V_{DGR}$      | 350   | 400   | 450   | 500   | Vdc                          |
| Gate-Source Voltage  | $V_{GS}$       | $\pm 20$                                      |       |       |       | Vdc                          |
| Drain Current<br>Continuous  | $I_D$          | 60  |       | 50    |       | Adc                          |
| Pulsed   | $I_{DM}$       | 300   |       | 240   |       |                              |
| Turn-Off Rate of Change  | $di/dt$        | See Note 4 and Figure 15<br>in Considerations |       |       |       | A/ $\mu$ s                   |
| Gate Current — Pulsed  | $I_{GM}$       | 2   |       |       |       | Adc                          |
| Total Power<br>Dissipation @ $T_C = 25^\circ\text{C}$<br>Derate above $25^\circ\text{C}$ | $P_D$          | 500<br>4                                      |       |       |       | Watts<br>W/ $^\circ\text{C}$ |
| Operating and Storage Temperature Range  | $T_J, T_{stg}$ | -65 to 150                                    |       |       |       | $^\circ\text{C}$             |
| Mounting Torque (To heat sink with 10-32 screw) <sup>(1)</sup>                           | $\tau(m)$      | 20  |       |       |       | in-lb                        |
| Lead Torque (Lead to bus with 1/4-20 screw) <sup>(2)</sup>                               | $\tau(l)$      | 20  |       |       |       | in-lb                        |
| Per Unit Weight  | W              | 120   |       |       |       | grams                        |

### THERMAL CHARACTERISTICS

|  |                 |      |                    |
|--|-----------------|------|--------------------|
| Thermal Resistance Junction to Case  | $R_{\theta JC}$ | 0.25 | $^\circ\text{C/W}$ |
| Maximum Lead Temp. for Soldering Purposes,<br>1/8" from case for 5 seconds | $T_L$           | 275  | $^\circ\text{C}$   |

1. A Belleville washer of 0.472" O.D., 0.205" I.D., 0.024" thick and 150 pounds flat is recommended.
  2. The maximum penetration of the screw should be limited to 0.75".
- TMOS and Designers are trademarks of Motorola Inc.



**MOTOROLA**

**ELECTRICAL CHARACTERISTICS** ( $T_C = 25^\circ\text{C}$  unless otherwise noted)

| Characteristic   | Symbol        | Min | Max  | Unit |
|--|---------------|-----|------|------|
| <b>OFF CHARACTERISTICS</b>   |               |     |      |      |
| Drain-Source Breakdown Voltage<br>( $V_{GS} = 0, I_D = 5 \text{ mA}$ )   | $V_{(BR)DSS}$ | 350 | —    | Vdc  |
| MTE60N35   |               | 400 | —    |      |
| MTE60N40   |               | 450 | —    |      |
| MTE50N45   |               | 500 | —    |      |
| MTE50N50   |               |     |      |      |
| Zero Gate Voltage Drain Current<br>( $V_{DS} = 0.85 \text{ Rated } V_{DSS}, V_{GS} = 0$ )<br>( $T_J = 100^\circ\text{C}$ ) | $I_{DSS}$     | —   | 0.25 | mAdc |
|  |               | —   | 2.5  |      |
| Gate-Body Leakage Current<br>( $V_{GS} = 20 \text{ Vdc}, V_{DS} = 0$ )   | $I_{GSS}$     | —   | 500  | nAdc |

**ON CHARACTERISTICS\***

|   |              |     |       |      |
|---|--------------|-----|-------|------|
| Gate Threshold Voltage<br>( $I_D = 1 \text{ mA}, V_{DS} = V_{GS}$ )<br>( $T_J = 100^\circ\text{C}$ )  | $V_{GS(th)}$ | 2   | 4.5   | Vdc  |
|   |              | 1.5 | 4     |      |
| Static Drain-Source On-Resistance<br>( $V_{GS} = 10 \text{ Vdc}, I_D = 30 \text{ Adc}$ )<br>( $V_{GS} = 10 \text{ Vdc}, I_D = 25 \text{ Adc}$ )   | $r_{DS(on)}$ | —   | 0.075 | Ohms |
|   |              | —   | 0.100 |      |
| Drain-Source On-Voltage ( $V_{GS} = 10 \text{ V}$ )<br>( $I_D = 60 \text{ Adc}$ )<br>( $I_D = 30 \text{ Adc}, T_J = 100^\circ\text{C}$ )<br>( $I_D = 50 \text{ Adc}$ )<br>( $I_D = 25 \text{ Adc}, T_J = 100^\circ\text{C}$ ) | $V_{DS(on)}$ | —   | 4.5   | Vdc  |
|   |              | —   | 3.5   |      |
|   |              | —   | 5.2   |      |
|   |              | —   | 5     |      |
| Forward Transconductance<br>( $V_{DS} = 15 \text{ V}, I_D = 30 \text{ A}$ )<br>( $V_{DS} = 15 \text{ V}, I_D = 25 \text{ A}$ )  | $g_{fs}$     | 16  | —     | mhos |
|   |              | 20  | —     |      |

**DYNAMIC CHARACTERISTICS**

|                              |  |           |   |        |    |
|------------------------------|--|-----------|---|--------|----|
| Input Capacitance            | $(V_{DS} = 25 \text{ V}, V_{GS} = 0, f = 1 \text{ MHz})$ | $C_{iss}$ | — | 12,000 | pF |
| Output Capacitance           |  | $C_{oss}$ | — | 2,000  |    |
| Reverse Transfer Capacitance |  | $C_{rss}$ | — | 800    |    |


**SWITCHING CHARACTERISTICS\*** ( $T_J = 100^\circ\text{C}$ )

|   |  |          |   |       |    |
|---|--|----------|---|-------|----|
| Inductive Load, Clamped — MTE60N35 and MTE60N40 |  |          |   |       |    |
| Turn-Off Delay Time                             | $(V_{clamp} = 200 \text{ Vdc}, I_D = 30 \text{ Adc},$<br>$L = 25 \mu\text{H}, V_{in} = 10 \text{ Vdc}$<br>$R_{gen} = 50 \Omega)$ See Figures 13 and 14 | $t_{dv}$ | — | 1,300 | ns |
| Crossover Time                                  |  | $t_c$    | — | 325   |    |
| Current Fall Time                               |  | $t_{fi}$ | — | 200   |    |
| Inductive Load, Clamped — MTE50N45 and MTE50N50 |  |          |   |       |    |
| Turn-Off Delay Time                             | $(V_{clamp} = 250 \text{ Vdc}, I_D = 25 \text{ Adc},$<br>$L = 25 \mu\text{H}, V_{in} = 10 \text{ Vdc}$<br>$R_{gen} = 50 \Omega)$ See Figures 13 and 14 | $t_{dv}$ | — | 1,300 | ns |
| Crossover Time                                  |  | $t_c$    | — | 300   |    |
| Current Fall Time                               |  | $t_{fi}$ | — | 200   |    |

**SOURCE-DRAIN DIODE CHARACTERISTICS\***

|                       | Symbol   | Typical | Unit |
|-----------------------|----------|---------|------|
| Forward On-Voltage    | $V_{SD}$ | 2       | Vdc  |
| Forward Turn-On Time  | $t_{on}$ | 350     | ns   |
| Reverse Recovery Time | $t_{rr}$ | 2,000   | ns   |

\*Pulse Test: Pulse Width  $\leq 300 \mu\text{s}$ , Duty Cycle  $\leq 2\%$ .

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**TYPICAL CHARACTERISTICS**

**ON-REGION CHARACTERISTICS**

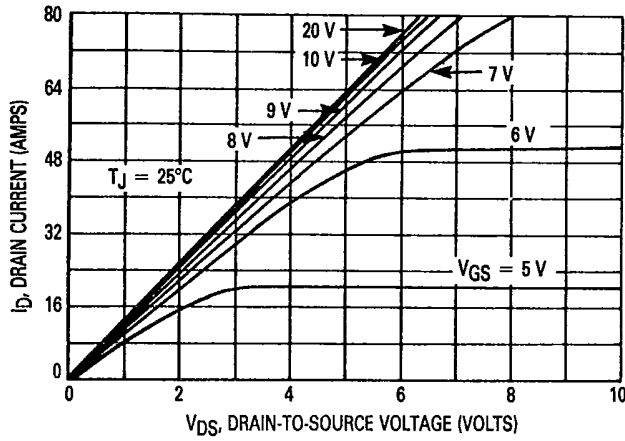


Figure 1. MTE50N45/50

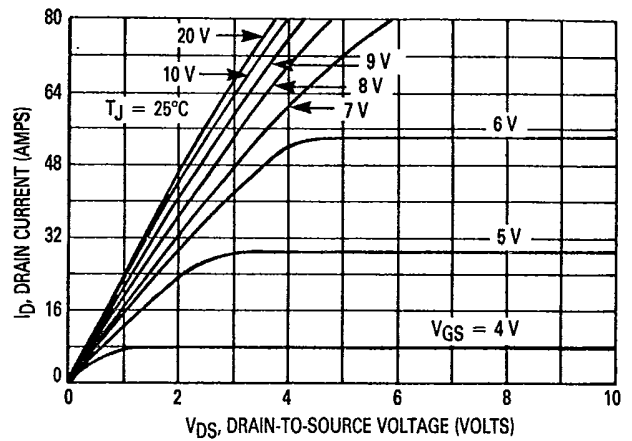


Figure 2. MTE60N35/40

**TRANSFER CHARACTERISTICS**

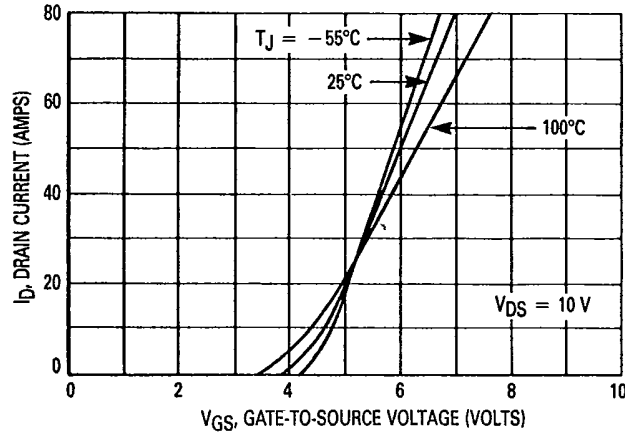


Figure 3. MTE50N45/50

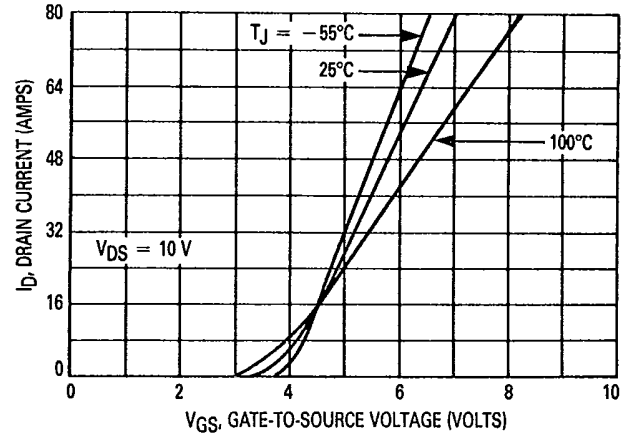


Figure 4. MTE60N35/40

**ON-RESISTANCE versus DRAIN CURRENT**

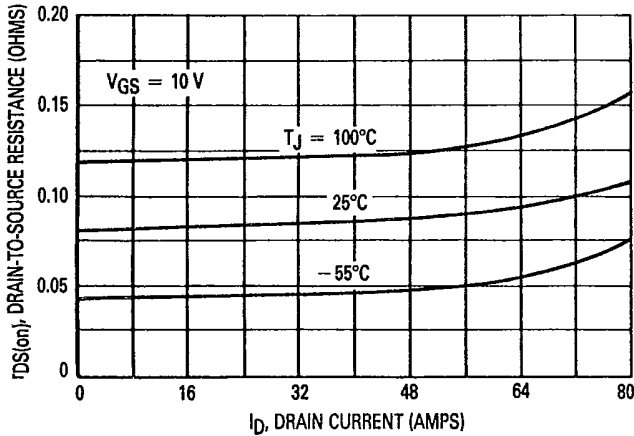


Figure 5. MTE50N45/50

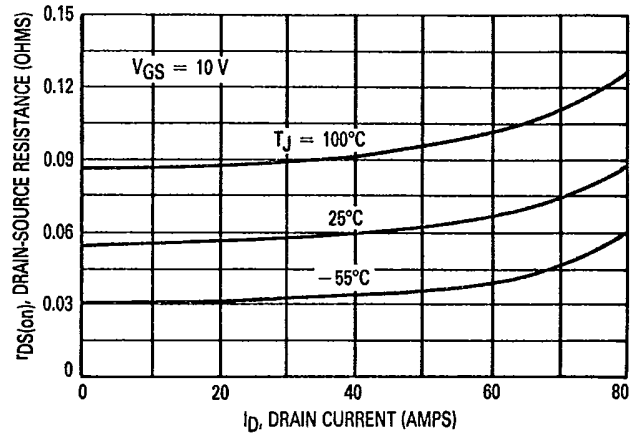


Figure 6. MTE60N35/40

TYPICAL CHARACTERISTICS

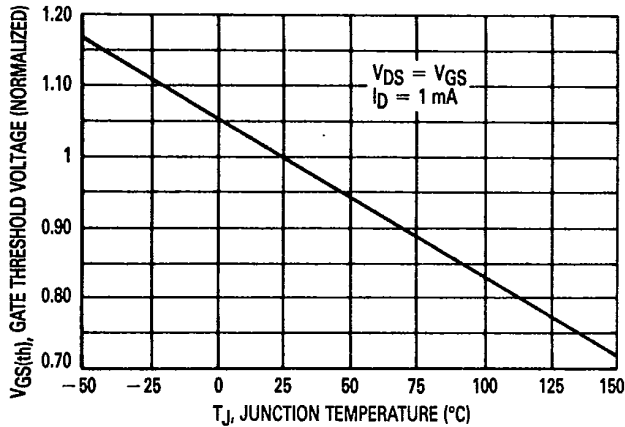


Figure 7. Gate-Threshold Voltage Variation with Temperature

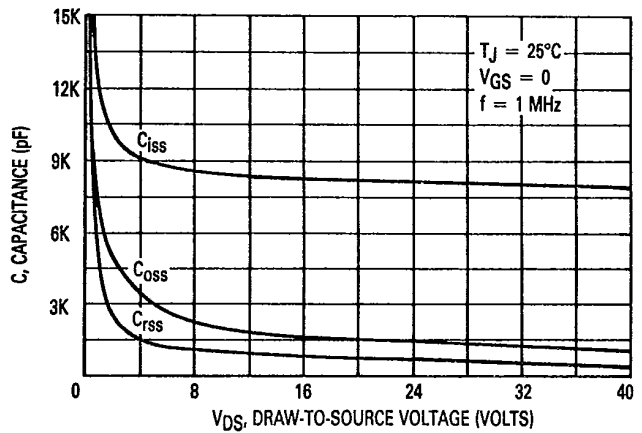


Figure 8. Capacitance Variation

SAFE OPERATING AREA INFORMATION

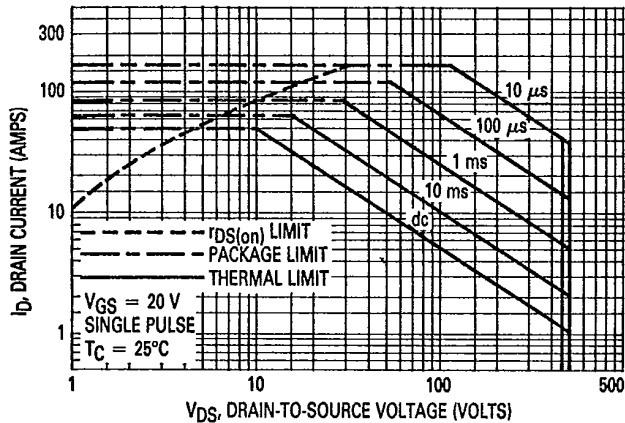


Figure 9. MTE50N45/50 Maximum Rated Forward Biased Safe Operating Area

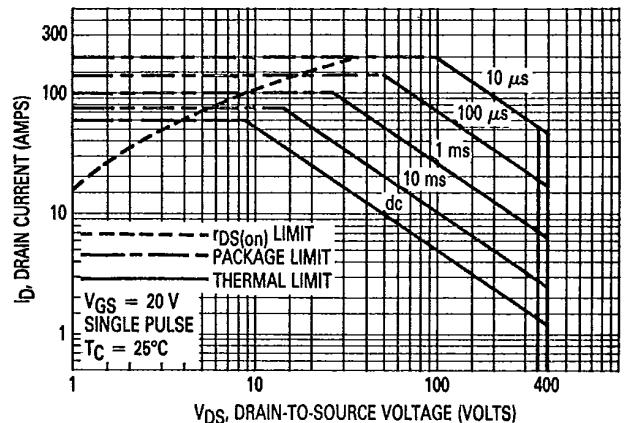


Figure 10. MTE60N35/40 Maximum Rated Forward Biased Safe Operating Area

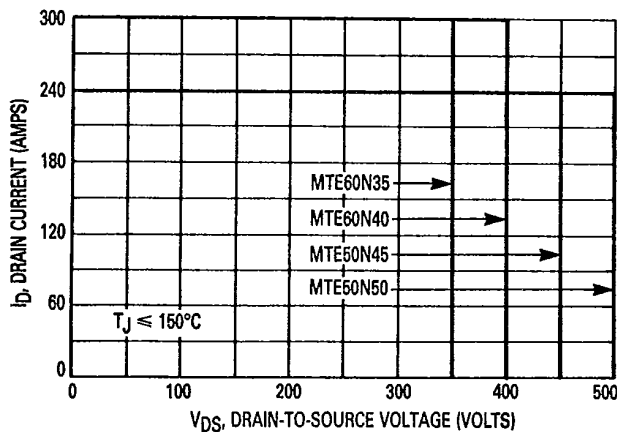


Figure 11. MTE60N35/40 AND MTE50N45/50 Maximum Rated Switching Safe Operating Area

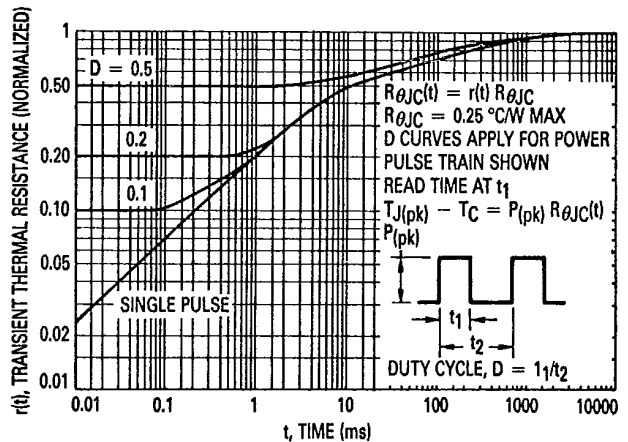


Figure 12. Thermal Response

**GUARANTEED SAFE OPERATING AREA**

The dc data presented in Figures 9 and 10 is for a single pulse, applied while maintaining the case temperature  $T_C$  at 25°C. For multiple pulses and case temperatures other than 25°C, the dc drain current at a case temperature of 25°C should be de-rated as follows:

$$I_D(T) = I_D(25^\circ) \left[ \frac{150 - T_C}{P_D \cdot R_{\theta JC} \cdot r(t)} \right]$$

where  $P_D$  is the maximum power rating at 25°C,  $R_{\theta JC}$  is the junction-to case thermal resistance, and  $r(t)$  is the normalized thermal response from Figure 15, corresponding to the appropriate pulse width and duty cycle.

**EXAMPLE:** Determine the maximum allowable drain current for an MTE50N50 at 25 volts drain voltage, with a pulse width of 10 ms and duty cycle of 50%, at a case temperature of 80°C.

From Figure 9, the dc drain current at  $V_{DS} = 25$  volts is 20 A. For a 10 ms pulse and duty cycle of 50%, Figure 12 gives an  $r(t)$  of 0.6; then, with  $P_D = 500$  watts at 25°C and  $R_{\theta JC} = 0.5^\circ\text{C/W}$ .

$$I_D = 20 \times \frac{150 - 80}{500 \times 0.25 \times 0.6} = 18.6 \text{ A}$$

The switching safe operating area in Figure 11 is the boundary that the load line may traverse without incurring damage to the device. The fundamental limits are the maximum rated peak drain current  $I_{DM}$ , the minimum drain-to-source breakdown voltage  $V_{BR(DSS)}$  and the maximum rated junction temperature. The boundaries are applicable for both turn-on and turn-off of the devices for rise and fall times of less than one microsecond.

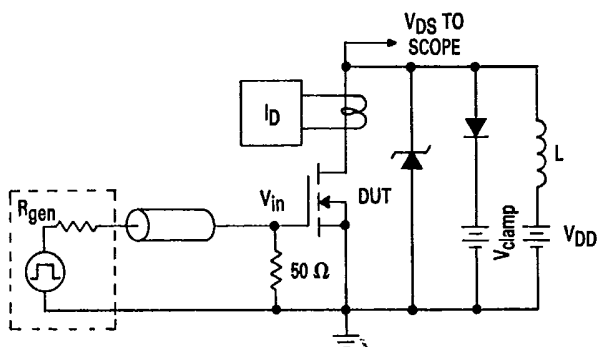


Figure 13. Inductive Load Switching Circuit

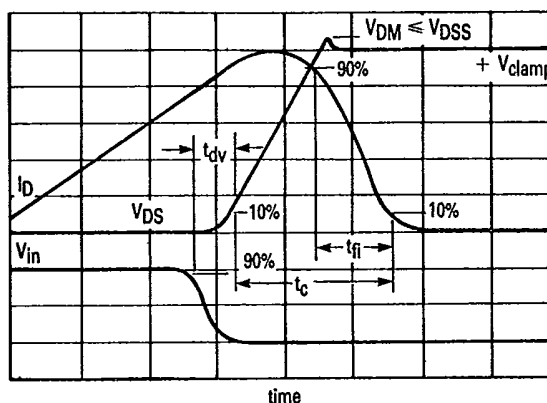
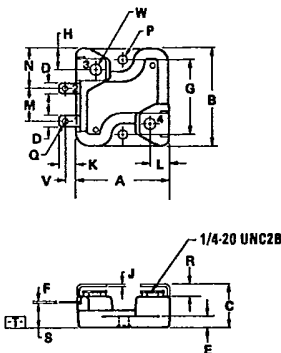


Figure 14. Clamped Inductive Load Switching Waveforms

**OUTLINE DIMENSIONS**



CASE 346-01  
MO-040AA

| DIM | MILLIMETERS |       | INCHES |       |
|-----|-------------|-------|--------|-------|
|     | MIN         | MAX   | MIN    | MAX   |
| A   | 53.09       | 53.84 | 2.090  | 2.120 |
| B   | 55.37       | 56.39 | 2.180  | 2.220 |
| C   | -           | 26.67 | -      | 1.050 |
| D   | 6.10        | 6.60  | 0.240  | 0.260 |
| E   | 6.60        | 7.11  | 0.260  | 0.280 |
| F   | 0.71        | 0.81  | 0.028  | 0.032 |
| G   | 43.31       | BSC   | 1.705  | BSC   |
| H   | 12.57       | 12.82 | 0.495  | 0.505 |
| J   | 1.52        | 1.62  | 0.060  | 0.064 |
| K   | 9.50        | 9.75  | 0.374  | 0.384 |
| L   | 10.21       | 10.46 | 0.402  | 0.412 |
| M   | 18.92       | 19.18 | 0.745  | 0.755 |
| N   | 23.67       | 23.93 | 0.932  | 0.942 |
| P   | 5.08        | 5.21  | 0.200  | 0.205 |
| Q   | 3.53        | 3.78  | 0.139  | 0.149 |
| R   | 6.76        | 7.26  | 0.266  | 0.286 |
| S   | 14.73       | 15.24 | 0.580  | 0.600 |
| V   | 5.33        | 5.84  | 0.210  | 0.230 |
| W   | 6.40        | 6.65  | 0.252  | 0.262 |
| X   | 7.37        | 7.87  | 0.290  | 0.310 |

**NOTES:**

1. DIMENSION A AND B ARE DATUMS.
2. [T] IS SEATING PLANE.
3. POSITIONAL TOLERANCE FOR MOUNTING HOLES:  
 $\phi \pm 0.36 (0.014) \text{ T } \text{A} \text{ B}$
4. DIMENSIONING AND TOLERANCING PER ANSI Y14.5, 1973.

**STYLE 1:**

- PIN 1. BASE
- 2. EMITTER
- 3. EMITTER
- 4. COLLECTOR
- 5. COLLECTOR

## CONSIDERATION IN DESIGNING WITH POWER MOSFETS

Depending on the frequency of operation, certain precautions must be taken to insure optimum reliability. When switching near the device maximum frequency, the high current and very fast switching capability of this device necessitates the use of the following protective measures:

- Note 1** As in any wideband circuit, good RF layout techniques must be maintained, i.e., short lead lengths, adequate ground planes and decoupled power supplies.
- Note 2** All overvoltage protection circuitry — free wheeling diodes, zeners, MOVs, snubber networks — should be placed directly between the drain-source or between the drain and a good, low inductance ac ground.
- Note 3** Since most "real world" loads are inductive, the fast turn-off peak flyback voltage ( $e = L di/dt$ ) must not exceed the  $V_{BR(DSS)}$  rating, an instantaneous voltage limit. The protective circuitry, including parasitics, must have response times commensurate with the Power MOSFET switching speed, e.g., rectifiers must have very short recovery times. The forward

recovery time  $t_{fr}$ , overshoot voltage  $V_{FM(DYN)}$  and reverse recovery time  $t_{rr}$  should be low to minimize the switching stress on the transistor.

- Note 4** Even with good RF layout and ideal clamping below the maximum  $V_{(BR)DSS}$  of the device, significant potentials may be generated across the package drain and source parasitic inductances during rapid turn off of a large magnitude of current. These induced voltages which are internal to the package add to the clamp voltage. Therefore, to protect the chips from excessive voltage, the  $di_D/dt$  must be limited in accordance to the peak voltage seen across the terminals of the device. The **MAXIMUM ALLOWABLE**  $di_D/dt$  must be limited in accordance to the peak  $V_{DS}$  appearing at the device terminals as shown in Figure 15.

For applications requiring slower switching speeds, increasing the gate drive impedance will increase the switching times. This can be accomplished by adding a resistor in series with the gate.

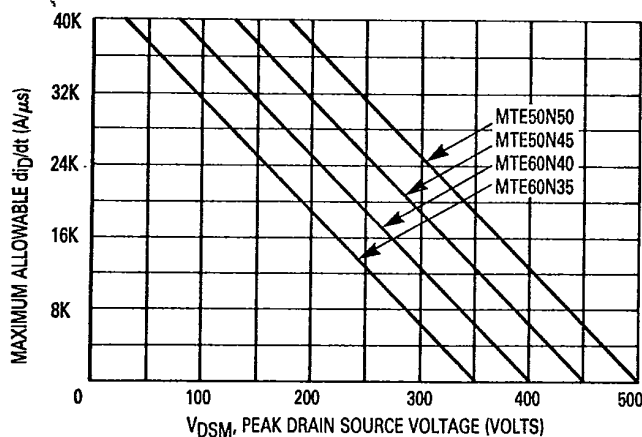


Figure 15. Maximum Allowable  $di_D/dt$  versus  
Drain Source Voltage

### TMOS SOURCE-TO-DRAIN CHARACTERISTICS

In the fabrication of a TMOS FET, a diode is formed across the source-to-drain terminals as shown in Figure 16. Reversal of the drain voltage will cause current flow in the reverse direction. This diode may be used in circuits

requiring external fast recovery diodes, therefore, typical characteristics of the on voltage, forward turnon and reverse recovery times are given.

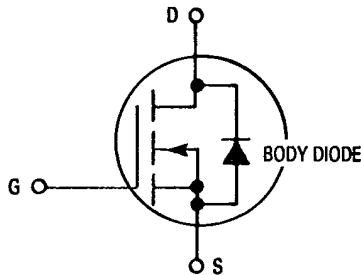


Figure 16. TMOS FET With Source-To-Drain Diode

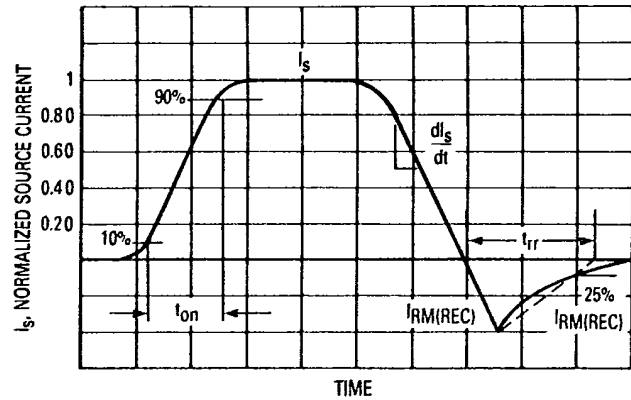


Figure 17. Diode Switching Waveform

NOTE: DUT is Shown as an N-Channel TMOS but can also be a P-Channel when appropriately connected. DUT Driver is the same device as DUT Diode (or Complement for P-Channel DUT Diode)

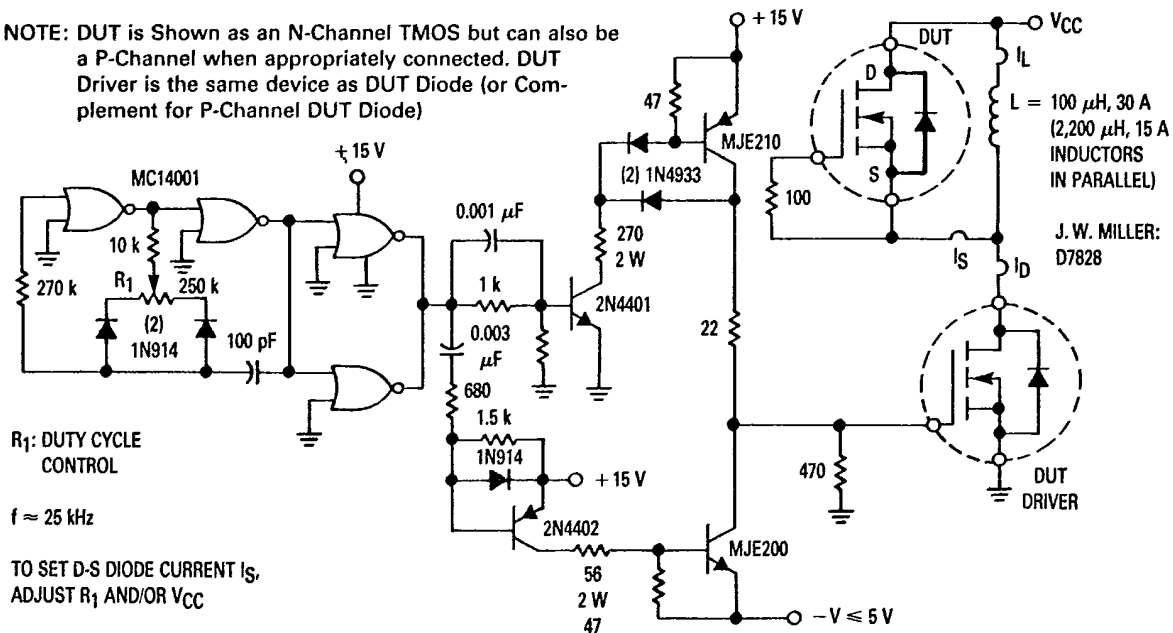


Figure 18. TMOS Diode Switching Test Circuit